

<b>Notice of References Cited</b>	Application/Control No. 10/692,854	Applicant(s)/Patent Under Reexamination KANEKO ET AL.	
	Examiner Tran N. Nguyen	Art Unit 2834	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,759,778	07-2004	Nishiyama et al.	310/156.53
	C	US-2005/0040716	02-2005	Schmid et al.	310/071
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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